

74AC175, 74ACT175

Quad D-Type Flip-Flop

The AC/ACT175 is a high-speed quad D-type flip-flop. The device is useful for general flip-flop requirements where clock and clear inputs are common. The information on the D-type inputs is stored during the LOW-to-HIGH clock transition. Both true and complemented outputs of each flip-flop are provided. A Master Reset input resets all flip-flops, independent of the Clock or D-type inputs, when LOW.

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer (OCM).

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.



April 2007

74AC175, 74ACT175 Quad D-Type Flip-Flop

Features

- I_{CC} reduced by 50%
- Edge-triggered D-type inputs
- Buffered positive edge-triggered clock
- Asynchronous common reset
- True and complement output
- Outputs source/sink 24mA
- ACT175 has TTL-compatible inputs

General Description

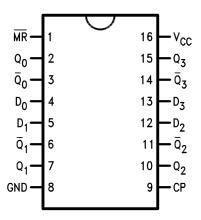
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Ordering Information

Order Number	Package Number	Package Description
74AC175SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
74AC175SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74AC175MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide
74AC175PC	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide
74ACT175SC	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Body
74ACT175SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74ACT175MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering number.

Connection Diagram

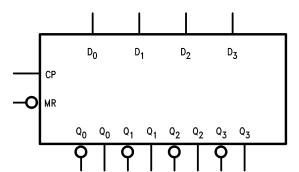


Pin Descriptions

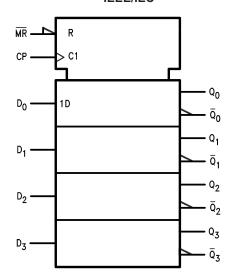
Pin Names	Description
D ₀ –D ₃	Data Inputs
СР	Clock Pulse Input
MR	Master Reset Input
Q ₀ –Q ₃	True Outputs
\overline{Q}_0 – \overline{Q}_3	Complement Outputs

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Logic Symbol



IEEE/IEC



Functional Description

The AC/ACT175 consists of four edge-triggered D-type flip-flops with individual D inputs and Q and \overline{Q} outputs. The Clock and Master Reset are common. The four flip-flops will store the state of their individual D inputs on the LOW-to-HIGH clock (CP) transition, causing individual Q and \overline{Q} outputs to follow. A LOW input on the Master Reset ($\overline{\rm MR}$) will force all Q outputs LOW and $\overline{\rm Q}$ outputs HIGH independent of Clock or Data inputs. The AC/ACT175 is useful for general logic applications where a common Master Reset and Clock are acceptable.

Truth Table

Inputs @ t_n , $\overline{MR} = H$	Outputs @ t _{n+1}			
D _n	Q _n	\overline{Q}_n		
L	L	Н		
Н	Н	L		

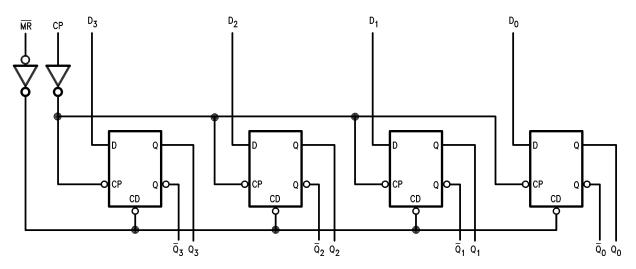
H = HIGH Voltage Level

L = LOW Voltage Level

t_n = Bit Time before Clock Pulse

t_{n+1} = Bit Time after Clock Pulse

Logic Diagram



Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Figure 1.

Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only.

Symbol	Parameter	Rating
V _{CC}	Supply Voltage	-0.5V to +7.0V
I _{IK}	DC Input Diode Current	
	$V_{I} = -0.5V$	–20mA
	$V_{I} = V_{CC} + 0.5V$	+20mA
VI	DC Input Voltage	-0.5V to V _{CC} + 0.5V
I _{OK}	DC Output Diode Current	
	$V_{O} = -0.5V$	–20mA
	$V_{O} = V_{CC} + 0.5V$	+20mA
Vo	DC Output Voltage	-0.5V to V _{CC} + 0.5V
Io	DC Output Source or Sink Current	±50mA
I _{CC} or I _{GND}	DC V _{CC} or Ground Current per Output Pin	±50mA
T _{STG}	Storage Temperature	–65°C to +150°C
TJ	Junction Temperature	140°C

Recommended Operating Conditions

The Recommended Operating Conditions table defines the conditions for actual device operation. Recommended operating conditions are specified to ensure optimal performance to the datasheet specifications. Fairchild does not recommend exceeding them or designing to absolute maximum ratings.

Symbol	Parameter	Rating
V _{CC}	Supply Voltage	
	AC	2.0V to 6.0V
	ACT	4.5V to 5.5V
V _I	Input Voltage	0V to V _{CC}
V _O	Output Voltage	0V to V _{CC}
T _A	Operating Temperature	–40°C to +85°C
ΔV / Δt	Minimum Input Edge Rate, AC Devices:	125mV/ns
	V_{IN} from 30% to 70% of V_{CC} , V_{CC} @ 3.3V, 4.5V, 5.5V	
ΔV / Δt	Minimum Input Edge Rate, ACT Devices:	125mV/ns
	$V_{\rm IN}$ from 0.8V to 2.0V, $V_{\rm CC}$ @ 4.5V, 5.5V	

DC Electrical Characteristics for AC

		V _{CC}		T _A = -	+25°C	T _A = -40°C to +85°C	
Symbol	Parameter	(V)	Conditions	Тур.	G	uaranteed Limits	Units
V _{IH}	Minimum HIGH Level	3.0	$V_{OUT} = 0.1V$	1.5	2.1	2.1	V
	Input Voltage	4.5	or V _{CC} – 0.1V	2.25	3.15	3.15	
		5.5		2.75	3.85	3.85	
V _{IL}	Maximum LOW Level	3.0	$V_{OUT} = 0.1V$	1.5	0.9	0.9	V
	Input Voltage	4.5	or V _{CC} – 0.1V	2.25	1.35	1.35	
		5.5		2.75	1.65	1.65	
V _{OH}	Minimum HIGH Level	3.0	$I_{OUT} = -50\mu A$	2.99	2.9	2.9	V
	Output Voltage	4.5		4.49	4.4	4.4	1
		5.5		5.49	5.4	5.4	1
			$V_{IN} = V_{IL}$ or V_{IH} :				
		3.0	$I_{OH} = -12mA$		2.56	2.46	
		4.5	$I_{OH} = -24mA$		3.86	3.76	1
		5.5	$I_{OH} = -24 \text{mA}^{(1)}$		4.86	4.76	1
V _{OL}	Maximum LOW Level	3.0	$I_{OUT} = 50\mu A$	0.002	0.1	0.1	V
	Output Voltage	4.5		0.001	0.1	0.1	
		5.5		0.001	0.1	0.1	
			$V_{IN} = V_{IL} \text{ or } V_{IH}$:				
		3.0	$I_{OL} = 12mA$		0.36	0.44	
		4.5	I _{OL} = 24mA		0.36	0.44	
		5.5	$I_{OL} = 24 \text{mA}^{(1)}$		0.36	0.44	1
I _{IN} ⁽³⁾	Maximum Input Leakage Current	5.5	$V_I = V_{CC}$, GND		±0.1	±1.0	μA
I _{OLD}	Minimum Dynamic	5.5	V _{OLD} = 1.65V Max.			75	mA
I _{OHD}	Output Current ⁽²⁾	5.5	V _{OHD} = 3.85V Min.			– 75	mA
I _{CC} ⁽³⁾	Maximum Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND		4.0	40.0	μA

Notes:

- 1. All outputs loaded; thresholds on input associated with output under test.
- 2. Maximum test duration 2.0ms, one output loaded at a time.
- 3. I_{IN} and I_{CC} @ 3.0V are guaranteed to be less than or equal to the respective limit @ 5.5V V_{CC} .

DC Electrical Characteristics for ACT

		V _{CC}		T _A = +	+25°C	T _A = -40°C to +85°C	
Symbol	Parameter	(V)	Conditions	Тур.	G	Guaranteed Limits	Units
V _{IH}	Minimum HIGH Level	4.5	$V_{OUT} = 0.1V$ or	1.5	2.0	2.0	V
	Input Voltage	5.5	V _{CC} – 0.1V	1.5	2.0	2.0	
V _{IL}	Maximum LOW Level	4.5	$V_{OUT} = 0.1V$ or	1.5	0.8	0.8	V
	Input Voltage	5.5	V _{CC} – 0.1V	1.5	0.8	0.8	1
V _{OH}	Minimum HIGH Level	4.5	$I_{OUT} = -50\mu A$	4.49	4.4	4.4	V
	Output Voltage	5.5		5.49	5.4	5.4	1
			$V_{IN} = V_{IL}$ or V_{IH} :				1
		4.5	$I_{OH} = -24mA$		3.86	3.76	
		5.5	$I_{OH} = -24 \text{mA}^{(4)}$		4.86	4.76]
V _{OL}	Maximum LOW Level	4.5	I _{OUT} = 50μA	0.001	0.1	0.1	V
	Output Voltage	5.5		0.001	0.1	0.1	
			$V_{IN} = V_{IL} \text{ or } V_{IH}$:				
		4.5	I _{OL} = 24mA		0.36	0.44	
		5.5	I _{OL} = 24mA ⁽⁴⁾		0.36	0.44	
I _{IN}	Maximum Input Leakage Current	5.5	$V_I = V_{CC}$, GND		±0.1	±1.0	μA
I _{CCT}	Maximum I _{CC} /Input	5.5	$V_I = V_{CC} - 2.1V$	0.6		1.5	mA
I _{OLD}	Minimum Dynamic	5.5	V _{OLD} = 1.65V Max.			75	mA
I _{OHD}	Output Current ⁽⁵⁾	5.5	V _{OHD} = 3.85V Min.			- 75	mA
I _{CC}	Maximum Quiescent Supply Current	5.5	$V_{IN} = V_{CC}$ or GND		4.0	40.0	μA

Notes:

- 4. All outputs loaded; thresholds on input associated with output under test.
- 5. Maximum test duration 2.0ms, one output loaded at a time.

AC Electrical Characteristics for AC

			T _A	T _A = +25°C, C _L = 50pF		$T_A = -40$ °C to +85°C, $C_L = 50$ pF		
Symbol	Parameter	V _{CC} (V) ⁽⁶⁾	Min.	Тур.	Max.	Min.	Max.	Units
f _{MAX}	Maximum Clock Frequency	3.3	149	214		139		MHz
		5.0	187	244		187		
t _{PLH}	Propagation Delay,	3.3	2.0	9.5	12.0	2.0	13.5	ns
	$CP \text{ to } Q_n \text{ or } \overline{Q}_n$	5.0	1.5	7.0	9.0	1.0	9.5	
t _{PHL}	Propagation Delay,	3.3	2.5	8.5	13.0	2.0	14.5	ns
	CP to Q_n or \overline{Q}_n	5.0	1.5	6.0	9.5	1.5	10.5	
t _{PLH}	Propagation Delay,	3.3	3.0	7.5	12.5	2.5	13.5	ns
	MR to Q _n	5.0	2.0	5.5	9.0	1.5	10.0	
t _{PHL}	Propagation Delay,	3.3	3.0	8.5	11.0	2.5	12.5	ns
	MR to Q _n	5.0	2.0	6.0	8.5	1.5	9.0	

Note

6. Voltage range 3.3 is $3.3V \pm 0.3V$. Voltage range 5.0 is $5.0V \pm 0.5V$.

AC Operating Requirements for AC

			T _A = +	-25°C, 50pF	$T_A = -40$ °C to +85°C, $C_L = 50$ pF	
Symbol	Parameter	$V_{CC}(V)^{(7)}$	Тур.	Gı	iaranteed Minimum	Units
t _S	Setup Time, HIGH or LOW,	3.3	2.0	4.5	4.5	ns
	D _n to CP	5.0	1.0	3.0	3.0	
t _H	Hold Time, HIGH or LOW,	3.3	1.0	1.0	1.0	ns
	D _n to CP	5.0	1.0	1.0	1.0	
t _W	CP Pulse Width,	3.3	2.5	4.5	4.5	ns
	HIGH or LOW	5.0	2.0	3.5	3.5	
t _W	MR Pulse Width, LOW	3.3	2.5	4.5	5.0	ns
		5.0	2.0	3.5	3.5	
t _{REC}	Recovery Time, MR to CP	3.3	-2.0	0	0	ns
		5.0	-1.0	0	0	

Note:

7. Voltage range 3.3 is 3.3V \pm 0.3V. Voltage range 5.0 is 5.0V \pm 0.5V.

AC Electrical Characteristics for ACT

			T _A = +25°C, C _L = 50pF		T _A = -40°C C _L =			
Symbol	Parameter	V _{CC} (V) ⁽⁸⁾	Min.	Тур.	Max.	Min.	Max.	Units
f _{MAX}	Maximum Clock Frequency	5.0	175	236		145		MHz
t _{PLH}	Propagation Delay, CP to Q_n or \overline{Q}_n	5.0	2.0	6.0	10.0	1.5	11.0	ns
t _{PHL}	Propagation Delay, CP to Q_n or \overline{Q}_n	5.0	2.0	7.0	11.0	1.5	12.0	ns
t _{PLH}	$\frac{\text{Propagation Delay,}}{\text{MR to }\overline{\textbf{Q}}_{\text{n}}}$	5.0	2.0	6.0	9.5	1.5	10.5	ns
t _{PHL}	Propagation Delay, MR to Q _n	5.0	2.0	5.5	9.5	1.5	10.5	ns

Note:

8. Voltage Range 5.0 is $5.0V \pm 0.5V$.

AC Operating Requirements for ACT

			T _A = +		$T_A = -40$ °C to +85°C, $C_L = 50$ pF	
Symbol	Parameter	$V_{CC}(V)^{(9)}$	Тур.	Gu	aranteed Minimum	Units
t _S (H)	Setup Time, D _n to CP	5.0	3.0	2.0	2.0	ns
t _S (L)			3.0	2.5	2.5	
t _H	Hold Time, HIGH or LOW, D _n to CP	5.0	0	1.0	1.0	ns
t _W	CP Pulse Width,HIGH or LOW	5.0	4.0	3.0	3.5	ns
t _W	MR Pulse Width, LOW	5.0	4.0	3.0	4.0	ns
t _{rec}	Recovery Time, MR to CP	5.0	0	0	0	ns

Note:

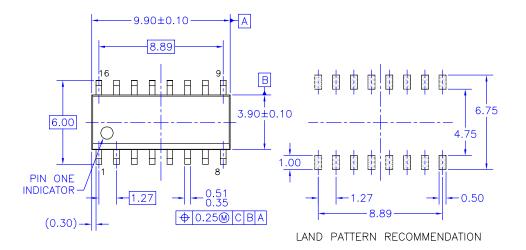
9. Voltage Range 5.0 is 5.0V \pm 0.5V.

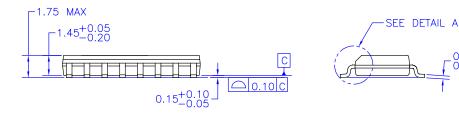
Capacitance

Symbol	Parameter	Conditions	Тур.	Units
C _{IN}	Input Capacitance	V _{CC} = OPEN	4.5	pF
C _{PD}	Power Dissipation Capacitance	V _{CC} = 5.0V	45.0	pF

Physical Dimensions

Dimensions are in millimeters unless otherwise noted.





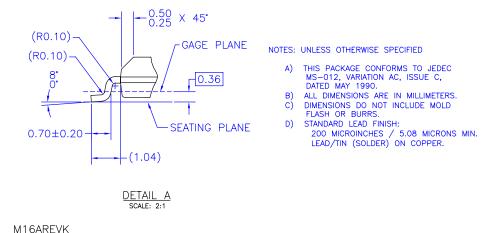
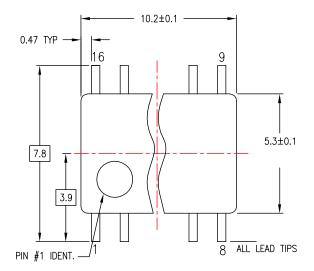
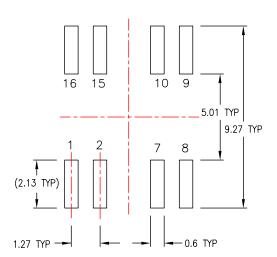


Figure 2. 16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A

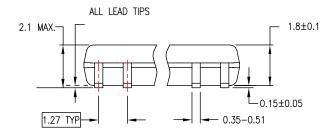
Physical Dimensions (Continued)

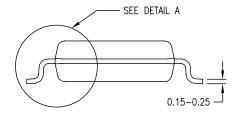
Dimensions are in millimeters unless otherwise noted.





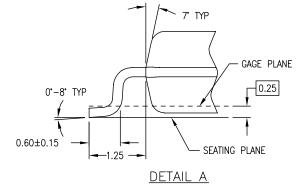
LAND PATTERN RECOMMENDATION





DIMENSIONS ARE IN MILLIMETERS

- NOTES:
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 B. DIMENSIONS ARE IN MILLIMETERS.
 C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

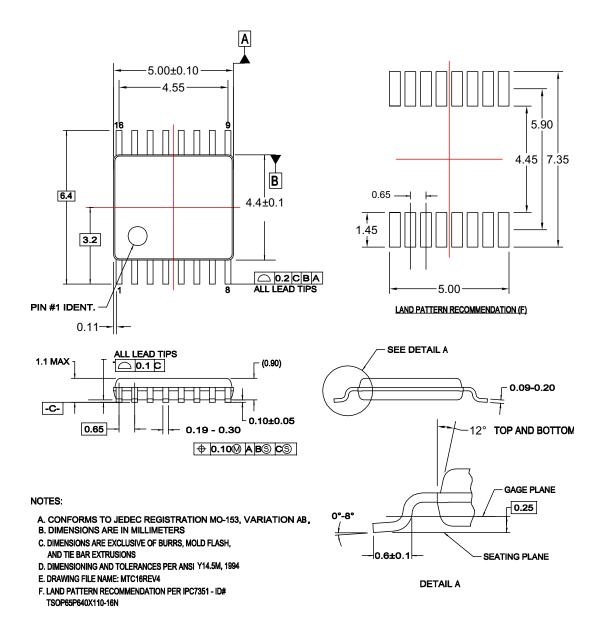


M16DREVC

Figure 3. 16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide Package Number M16D

Physical Dimensions (Continued)

Dimensions are in millimeters unless otherwise noted.



MTC16rev4

Figure 4. 16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC16

Physical Dimensions (Continued)

Dimensions are in inches (millimeters) unless otherwise noted.

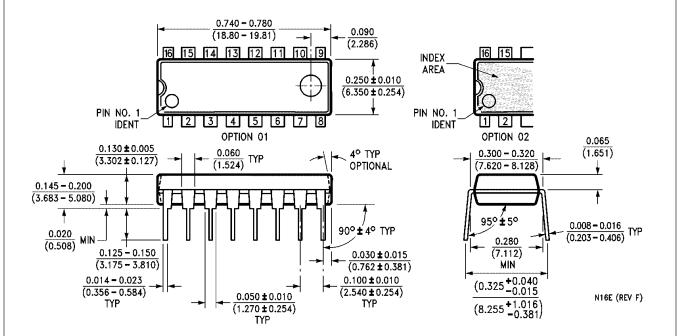


Figure 5. 16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E





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Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
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